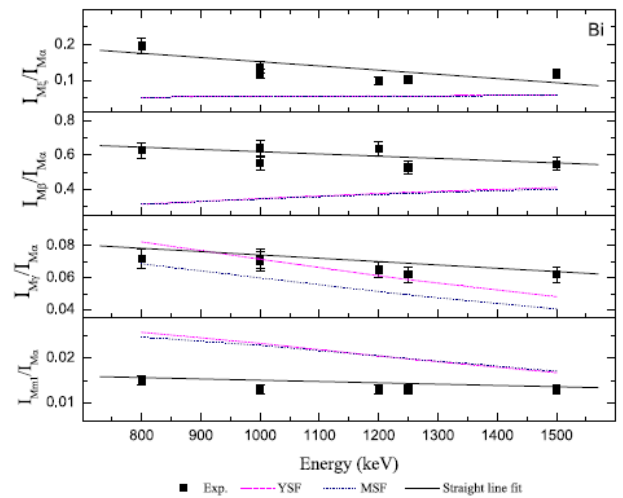
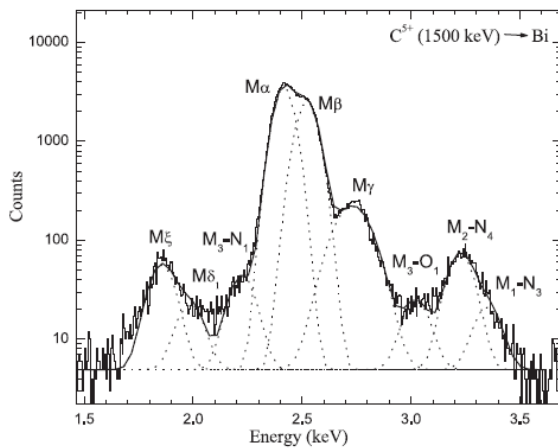


Low energy carbon ion induced M X-ray relative intensities for $_{70}\text{Yb}$, $_{82}\text{Pb}$ and $_{83}\text{Bi}$

The intensity ratios, I_{Mk}/I_{Mn} (exp) ($k = \xi, \beta, \gamma, m1$; $n = \alpha\beta, \alpha$), for $_{70}\text{Yb}$, $_{82}\text{Pb}$ and $_{83}\text{Bi}$ induced by the C^{q+} ($q = 4, 5$) ions having energies in the range 800 – 1500 keV have been measured using ECR ion source. These intensity ratios have been compared with those calculated using the ECPSSR model based carbon ion induced M_j ($j = 1-5$) sub-shell ionization cross sections, the X-ray emission rates based on the Dirac-Fock model, and two sets of the fluorescence and Coster-Kronig yields. Significant differences observed between the present measured and calculated ratios could be due to multiple-ionization induced in the investigated elements by the incident carbon ions.



The spectrum for $_{83}\text{Bi}$ M X-rays induced by the 1500 keV C^{5+} ion beam. The vertical step connected line, bold line and the dotted lines represent the measured, fitted M_{tot} and fitted M_k ($k = \xi, \delta, \gamma, (M_3-N_1), \alpha, \beta, \gamma, Mm_1[(M_3-O_1)+(M_2-N_4)+(M_1-N_3)]$) X-ray peaks, respectively.

A plot of the present measured intensity ratios $I_{Mk}/I_{M\alpha}$ (Exp) ($k = \xi, \beta, \gamma, m1$) along with $I_{Mk}/I_{M\alpha}$ (YSF) and $I_{Mk}/I_{M\alpha}$ (MSF) for $_{83}\text{Bi}$ as a function of incident carbon energy. The straight bold lines have been drawn across the present measured values to guide the eye.

Ref. :

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